





an Open Access Journal by MDPI

Recent Trends in Image Processing and Pattern Recognition

Guest Editors:

Prof. Dr. KC Santosh
Prof. Dr. Myra Conway
Prof. Dr. Ashutosh Kumar
Singh
Dr. Aaisha Makkar
Prof. Dr. Antoine Vacavant
Prof. Dr. Anas Abou El Kalam
Dr. Mohamed-Rafik Bouguelia
Prof. Dr. Ravindra Hegadi

Deadline for manuscript submissions: **closed (7 March 2024)**

Message from the Guest Editors

The 6th International Conference on Recent Trends in Image Processing and Pattern Recognition (RTIP2R) aims to attract current and/or advanced research on image processing, pattern recognition, computer vision, and machine learning. The RTIP2R will take place at the University of Derby, United Kingdom on December 07–08, 2023 in collaboration with the 2AI Research Lab—Computer Science, University of South Dakota (USA).

Authors of selected papers from the conference will be invited to submit extended versions of their original papers and contributions under the conference topics (new papers that are closely related to the conference themes are also welcome).

We, however, are not limited to RIP2R 2023 to increase the number of submissions.

Topics of interest include, but are not limited to, the following:

- Signal and image processing.
- Computer vision and pattern recognition.
- Machine learning.
- Data analytics.
- Federated learning.
- Pattern recognition and machine learning for the Internet of things (IoT).
- Information retrieval.



We look forward to receiving your contributions.

Specials

Output

Description:







an Open Access Journal by MDPI

Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

Author Benefits

Open Access: free for readers, with article processing charges (APC) paid by authors or their institutions.

High Visibility: indexed within Scopus, SCIE (Web of Science),

CAPlus / SciFinder, Inspec, and other databases.

Journal Rank: JCR - Q2(Electrical and Electronic Engineering) CiteScore - Q2 (Electrical

and Electronic Engineering

Contact Us